


<b>Search Notes</b>  	<b>Application/Control No.</b>  10589478	<b>Applicant(s)/Patent Under Reexamination</b>  BADAQUI ET AL.
	<b>Examiner</b>  Stefan Krueer	<b>Art Unit</b>  3654

SEARCHED			
Class	Subclass	Date	Examiner
187	319, 327, 330	06/09/2008	SHK
B66B	13/12		

SEARCH NOTES		
Search Notes	Date	Examiner
PLUS	06/09/2008	SHK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner